## Appendix A. Identification of Amended Material

The paragraphs encompassing page 1, line 12 - page 2, line 16 are amended as follows:

The present invention provides an electronic structure, comprising:

an internally circuitized substrate having a metallic plane on a first surface of the substrate;

and

metallic plane.

a redistribution structure having N dielectric layers <u>denoted as dielectric layers 1, 2, ..., N</u>, N metal planes <u>denoted as metal planes 1, 2, ..., N</u>, and a microvia structure through the N dielectric layers, wherein N is at least 2, wherein dielectric layer 1 is on the first surface of the substrate and on the metallic plane, wherein metal plane J is on dielectric layer J for J = 1, 2, ..., N, wherein dielectric layer I is on dielectric layer I-1 and on metal [layer] <u>plane</u> I-1 for I = 2, ..., N, and wherein the microvia structure electrically couples metal plane N to the metallic plane.

The present invention provides a method for forming an electronic structure, comprising: providing an internally circuitized substrate having a metallic plane on a first surface of the substrate; and

forming a redistribution structure including forming N dielectric layers <u>denoted as</u>

<u>dielectric layers 1, 2, ..., N</u>, forming N metal planes <u>denoted as metal planes 1, 2, ..., N</u>, and

forming a microvia structure through the N dielectric layers such that the microvia structure

electrically couples metal plane N to the metallic plane, wherein N is at least 2, and wherein

forming the N dielectric layers and the N metal [layers] <u>planes</u> includes setting a dummy index

J=0 and looping over J as follows:

adding 1 to J;

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if J = 1 then forming dielectric layer 1 on the first surface of the substrate and on the metallic plane, else forming dielectric layer J on dielectric layer J-1 and on metal plane J-1;

forming metal plane J on dielectric layer J; and

if J < N then returning to adding 1 to J and continuing the looping, else ending the looping.

The paragraph beginning on page 13, line 4 is amended as follows:

FIG. 2 illustrates advantages of the multiple redistribution layers (e.g., the redistribution layers 60, 70, 80, and 90) on the top surface 48 and on the bottom surface 49 of the substrate 10. The redistribution layers serve as buildup layers which provides a capability of adding extra wiring layers; e.g., the metal planes 140-141 and 150-151. The extra wiring level, coupled with the microvias (e.g., the microvias 132-135 and 144-148) in the multiple redistribution layers, provide extra wireout capability for making more efficient use of space and increasing overall wiring density. In addition, there is increased flexibility in how electrically conductive structure may be distributed inasmuch as a metal plane on each redistribution layer may be any metal distribution, included a signal plane, a power plane, or a ground plane. With the multiple redistribution layers, any metal [level] or metallic plane on a redistribution layer on the top surface 48 of the substrate 10 may be electrically coupled to any metal [level] or metallic plane on a redistribution layer on the bottom surface 49 of the substrate 10 or to any internal layer of the substrate 10, in light of the electrically conductive paths facilitated by the microvias in the redistribution layers 60, 70, 80, and 90 and the PTHs in the substrate 10. FIG. 2 illustrates several

of such electrically conductive paths. For example, the metal plane 140 is electrically coupled to the metal plane 151 through the path of the conductive region 137, the microvia 133, the conductive pad 42, the PTH 32, the conductive pad 45, the microvia 135, and the microvia 148. As another example, the electronic device 110 is coupled to the conductive pad 44 of the PTH 31 by a path that includes the conductive pad 128, the solder member 121, the microvia 145, the conductive pad 131, the microvia 132, the conductive pad 41, the PTH 31, and the conductive pad 44. The electronic device 110 may be coupled to wiring in the redistribution layer 70 through the solder member 122 and the microvia 146, or to wiring in the redistribution layer 60 through the solder member 120 and the microvia 144 or through the solder member 121 and the microvias 145 and 132. The number and types of conductive paths facilitated by the multiple redistribution layers of the present invention are virtually unlimited. FIG. 3 also includes the aforementioned features and advantages.

The paragraph beginning on page 15, line 11 is amended as follows:

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As illustrated for the embodiments of FIGS. 2 and 3, the multiple redistribution structure on either the top surface 48 or the bottom surface 49 of the substrate 10 has N dielectric layers (denoted as dielectric layers 1, 2, ..., N), N metal planes (denoted as metal planes 1, 2, ..., N), and a microvia structure, wherein  $N \ge 2$ . Dielectric layer 1 (i.e., redistribution layer 60 or 80) is on the top surface 48 or the bottom surface 49 of the substrate 10 and thus also on a metallic plane; i.e., on the metal plane 51 or the metal plane 52, respectively. Thus, the metals planes 51 and 52 are each called a "metallic plane" for purposes of the notation being discussed herein. Metal [level] plane 1 (i.e., metal plane 140 or 141) is on dielectric layer 1, dielectric layer 2 (i.e., redistribution

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layer 70 or 90) is on dielectric layer 1 and metal [layer] plane 1, metal [layer] plane 2 (i.e., metal plane 150 or 151) is on dielectric layer 2, ..., dielectric layer N is on dielectric layer N-1 and metal [layer] plane N-1, and metal [layer] plane N is on dielectric layer N. The microvia structure electrically couples the metal [layer] plane N to the metallic plane (i.e., the metal plane 51 or the metal plane 52) by a collection of microvias coupled with intervening metal [levels] planes. The microvia structure includes a microvia or a portion of a microvia through each of the N dielectric layers. Many such combinations of microvias are possible. An example microvia combination is N microvias (i.e., a microvia in each dielectric layer) such that microvia J is electrically coupled to microvia J-1 by metal plane J-1 for J=2, 3, ..., N. To illustrate, FIG. 3 has N=3 and shows: microvia 345 electrically coupled to microvia 385 by metal plane 380 (specifically, conductive pad 386 in metal plane 380), microvia 385 electrically coupled to microvia 334 by metal plane 340 (specifically, conductive pad 338 in metal plane 340), and microvia 334 electrically coupled to metal plane 51 by conductive pad 33, which electrically couples the metal plane 395 to the metal plane 51 in light of the fact that conductive pad 346 of metal plane 395 is integral with, and thus electrically connected with, the conductive plating of the microvia 346. Another microvia combination includes a microvia that passes through two or more dielectric layers (e.g., the microvia 144 of FIG. 2). For example and although not shown explicitly in FIG. 3, a microvia could pass through redistribution layers 360, 370, and 390, or through redistribution layers 370 and 390, just as microvia 144 of FIG. 2 passes through redistribution layers 60 and 70. Thus in FIG. 3, a microvia passing through redistribution layers 370 and 390 could be electrically coupled by metal plane 340 to a microvia (e.g., the microvia 332, 333, or 334) in redistribution layer 360.

Claims 1, 2, 6, 19, and 22 are amended as follows:

1. (AMENDED) An electronic structure, comprising:

an internally circuitized substrate having a metallic plane on a first surface of the substrate; and

a redistribution structure having N dielectric layers <u>denoted as dielectric layers 1, 2, ..., N</u>, N metal planes <u>denoted as metal planes 1, 2, ..., N</u>, and a microvia structure through the N dielectric layers, wherein N is at least 2, wherein dielectric layer 1 is on the first surface of the substrate and on the metallic plane, wherein metal plane J is on dielectric layer J for J = 1, 2, ..., N, wherein dielectric layer I is on dielectric layer I-1 and on metal [layer] <u>plane</u> I-1 for I = 2, ..., N, and wherein the microvia structure electrically couples metal plane N to the metallic plane.

- 2. (AMENDED) The electronic structure of claim 1, wherein the microvia structure includes N microvias denoted as microvias 1, 2, ..., N, wherein the microvia K passes through dielectric layer K for K = 1, 2, ..., N, wherein metal plane N is electrically coupled to microvia N, wherein metal plane J-1 electrically couples microvia J to microvia J-1 for J = 2, 3, ..., N, and wherein microvia 1 is electrically coupled to the metallic plane.
- 6. (AMENDED) The electronic structure of claim 4, wherein the microvia structure further includes M-1 second microvias denoted as second microvias 1, 2, ..., M-1, and wherein the second microvia K passes through dielectric layer K for K = 1, 2, ..., M-1, wherein the metal plane M-1 electrically couples the first microvia to second microvia M-1, wherein if M > 2 then metal plane J-1 electrically couples second microvia J to second microvia J-1 for J = 2, 3, ..., M-1, and

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wherein second microvia 1 is electrically coupled to the metallic plane.

19. (AMENDED) The electronic structure of claim 17, wherein the electronic structure includes at least one power plane, and wherein a thickness of the redistribution [layer] structure is large enough that a nearest distance between the solder member and any power plane of the at least one power plane is not less than a predetermined minimum distance value.

22. (AMENDED) The electronic structure of claim 21, further comprising a second metallic plane on the second surface of the substrate and a second redistribution structure having P second dielectric layers denoted as second dielectric layers 1, 2, ..., P, P second metal planes denoted as second metal planes 1, 2, ..., P, and a second microvia structure through the P second dielectric layers, wherein P is at least 1, wherein second dielectric layer 1 is on the second surface of the substrate and on the second metallic plane, wherein second metal plane J is on second dielectric layer J for J = 1, 2, ..., P, wherein if I > 1 then second dielectric layer I is on second dielectric layer I-1 and on second metal [layer] plane I-1 for I = 2, ..., P, wherein the microvia structure electrically couples the second metal plane P to the second metallic plane, and wherein the second metallic plane is electrically coupled to the PTH.